

Electrical Characteristics

at $T_{\rm j}$ = 25 °C, unless otherwise specified.

Parameter	Symbol		Values		Unit
		min.	typ.	max.	

Static Characteristics

Drain-source breakdow $V_{GS} = 0, I_D = 0.25 \text{ mA}$	wn voltage	$V_{(BR)DSS}$	50	_	_	V
Gate threshold voltage $V_{\text{GS}} = V_{\text{DS}}, I_{\text{D}} = 1 \text{ mA}$)	$V_{ m GS(th)}$	1.5	2.0	2.5	
Zero gate voltage drai $V_{GS} = 0 V, V_{DS} = 50 V$	n current	I _{DSS}				μΑ
	<i>T</i> _j = 25 °C <i>T</i> _j = 125 °C			1 100	10 300	
Gate-source leakage of $V_{GS} = 20 \text{ V}, V_{DS} = 0$	current	I _{GSS}				
	$T_{\rm j}$ = 25 °C $T_{\rm j}$ = 150 °C			10 2	100 4	nA μA
$\overline{ \text{Drain-source on-state} } \\ V_{\text{GS}} = 4.5 \text{ V}, I_{\text{D}} = 12 \text{ A} \\ \end{array}$	resistance	R _{DS(on)}	_	0.05	0.06	Ω

Dynamic Characteristics

Forward transconductance	g_{fs}				S
$V_{\text{DS}} \ge 2 \times I_{\text{D}} \times R_{\text{DS(on)max}}, I_{\text{D}} = 12 \text{ A}$		12	17	22	
Input capacitance	$C_{\rm iss}$				pF
$V_{\rm GS}$ = 0, $V_{\rm DS}$ = 25 V, f = 1 MHz		800	1050	1400	
Output capacitance	$C_{\rm oss}$				
$V_{\rm GS} = 0, \ V_{\rm DS} = 25 \ V, f = 1 \ MHz$		-	500	750	
Reverse transfer capacitance	$C_{\rm rss}$				
$V_{\rm GS} = 0, \ V_{\rm DS} = 25 \ V, f = 1 \ MHz$		-	200	300	
Turn-on time t_{on} , $(t_{on} = t_{d(on)} + t_r)$	t _{d(on)}	-	25	40	ns
$V_{\rm CC} = 30 \text{ V}, V_{\rm GS} = 5 \text{ V}, I_{\rm D} = 3 \text{ A}, R_{\rm GS} = 50 \Omega$	<i>t</i> r	-	60	90	
Turn-off time t_{off} , $(t_{\text{off}} = t_{\text{d(off)}} + t_{\text{f}})$ $V_{\text{CC}} = 30 \text{ V}$, $V_{\text{GS}} = 5 \text{ V}$, $I_{\text{D}} = 3 \text{ A}$, $R_{\text{GS}} = 50 \Omega$	t _{d(off)}	-	100	130	
	t _f	-	75	95	





Electrical Characteristics (cont'd)

at $T_{\rm j}$ = 25 °C, unless otherwise specified.

Parameter	Symbol	Values			Unit
		min.	typ.	max.	

Reverse Diode

Continuous source current	Is	-	-	25	A
Pulsed source current	I _{SM}	-	-	100	
Diode forward on-voltage $I_{\rm F}$ = 25 A, $V_{\rm GS}$ = 0 V	$V_{\rm SD}$	_	1.3	1.8	V
Reverse recovery time $I_{\rm F} = I_{\rm S}, di_{\rm F}/dt = 100 \text{ A}/\mu \text{s}, V_{\rm R} = 30 \text{ V}$	t _{rr}	_	150	_	ns
Reverse recovery charge $I_{\rm F} = I_{\rm S}, {\rm d}i_{\rm F}/{\rm d}t = 100 {\rm A}/{\rm \mu s}, V_{\rm R} = 30 {\rm V}$	Qrr	_	1.0	_	μC

Temperature Sensor

Forward voltage	$V_{TS(on)}$				V
$I_{\text{TS(on)}} = 5 \text{ mA}, T_{\text{j}} = -55 \dots + 150 \text{ °C}$		-	1.3	1.4	
Sensor override, $t_p \le 100 \ \mu s$ $T_j = -55 \ \dots + 160 \ ^{\circ}C$		_	_	10	
Forward current $T_{\rm j} = -55 \dots + 150 ^{\circ}\text{C}$ Sensor override, $t_{\rm p} \le 100 \mu\text{s}$	I _{TS(on)}	_	_	5	mA
$T_{\rm j} = -55 \dots + 160 ^{\circ}{\rm C}$		-	_	600	
Holding current, $V_{TS(off)} = 5 \text{ V}$, $T_j = 25 \text{ °C}$ $T_j = 150 \text{ °C}$	I _H	0.05 0.05	0.1 0.2	0.5 0.3	
Switching temperature $V_{\text{TS}} = 5 \text{ V}$	T _{TS(on)}	150	_	_	°C
Turn-off time $V_{\text{TS}} = 5 \text{ V}, I_{\text{TS(on)}} = 2 \text{ mA}$	t _{off}	0.5	_	2.5	μs



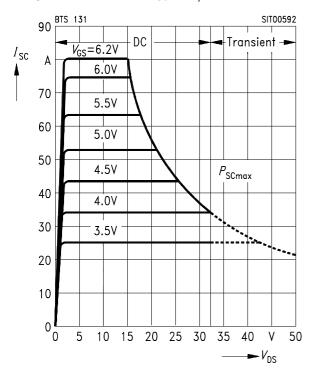
Examples for short-circuit protection

at $T_i = -55 \dots + 150 \text{ °C}$, unless otherwise specified.

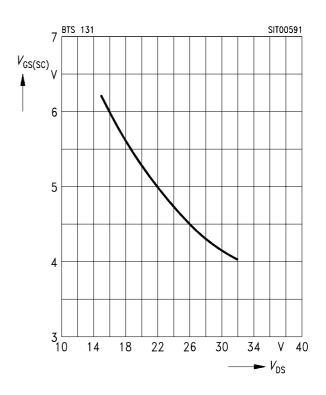
Parameter	Symbol	Examples			Unit
		1	2	-	
Drain-source voltage	$V_{\sf DS}$	15	30	-	V
Gate-source voltage	V _{GS}	6.2	4.1	_	
Short-circuit current	I _{SC}	≤ 80	≤ 37	_	A
Short-circuit dissipation	P _{SC}	1200	1100	_	W
Response time $T_j = 25 \degree$ C, before short circuit	t _{SC(off)}	25	25	_	ms

Short-circuit protection $I_{SC} = f(V_{DS})$ Parameter: V_{GS}

Diagram to determine $I_{\rm SC}$ for $T_{\rm i} = -55... + 150$ °C

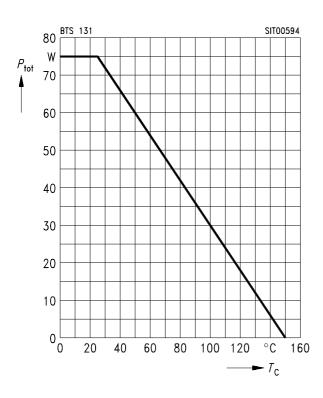


Max. gate voltage $V_{GS(SC)} = f(V_{DS})$ Parameter: $T_j = -55 \dots + 150$ °C

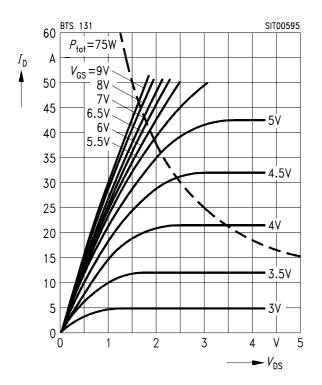




Max. power dissipation $P_{tot} = f(T_c)$

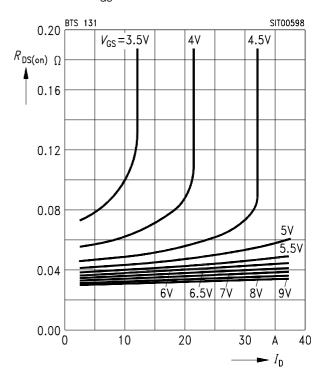


Typical output characteristics $I_{\rm D} = f(V_{\rm DS})$ Parameter: $t_{\rm p} = 80 \ \mu s$

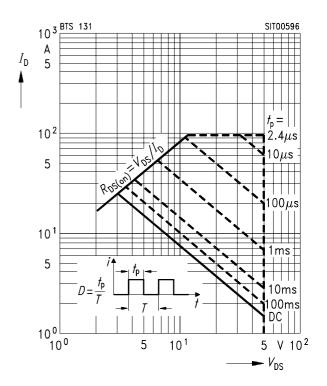


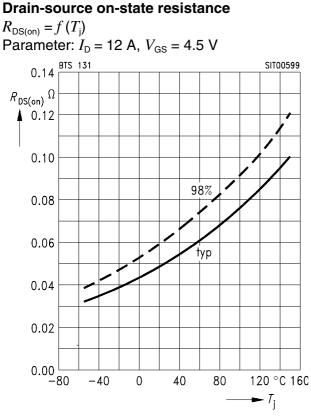
Typ. drain-source on-state resistance $R_{\text{DS(on)}} = f(I_{\text{D}})$

Parameter: V_{GS}

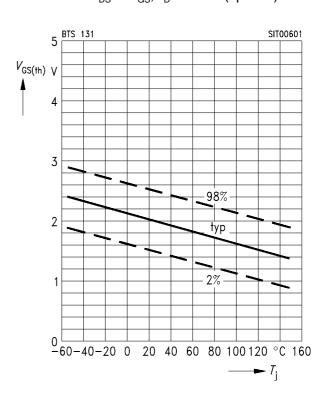


Safe operating area $I_{\rm D} = f(V_{\rm DS})$ Parameter: D = 0.01, $T_{\rm C} = 25 \ ^{\circ}{\rm C}$



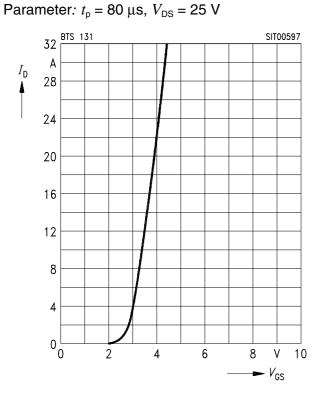


Gate threshold voltage $V_{GS(th)} = f(T_i)$ Parameter: $V_{DS} = V_{GS}$, $I_D = 1$ mA (spread)

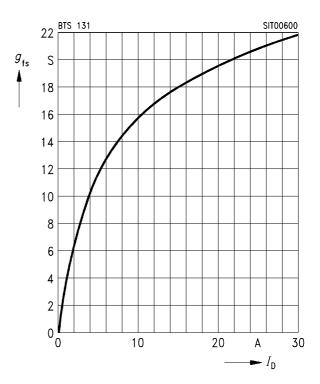


Typ. transfer characteristic

 $I_{\rm D} = f(V_{\rm GS})$



Typ. transconductance $g_{fs} = f(I_D)$ Parameter: $t_p = 80 \ \mu s$, $V_{DS} = 25 \ V$

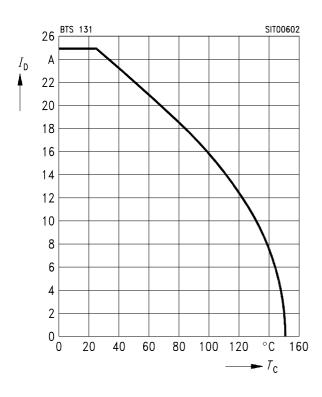


ineon



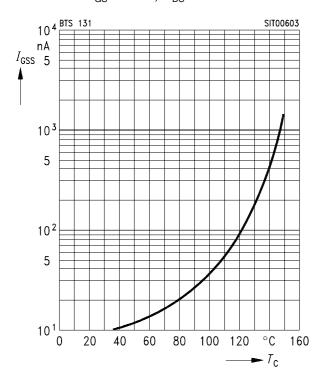
Continuous drain current $I_{\rm D} = f(T_{\rm C})$

Parameter: $V_{\rm GS} \ge 4.5 \text{ V}$



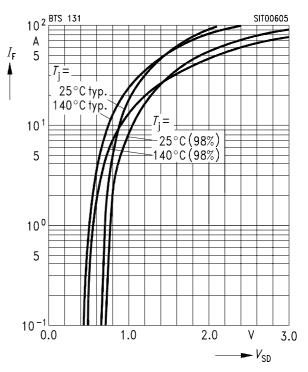
Typ. gate-source leakage current $I_{GSS} = f(T_{C})$

Parameter: $V_{GS} = 10 \text{ V}, V_{DS} = 0$

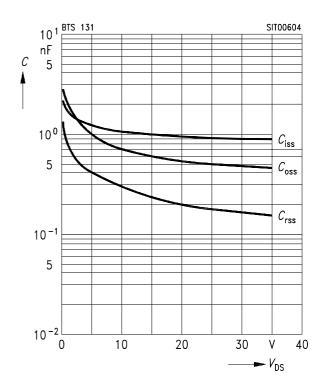


Forward characteristics of reverse diode $I_{\rm F}$ = $f\left(V_{\rm SD}\right)$

Parameter: T_j , $t_p = 80 \ \mu s$ (spread)



Typ. capacitances $C = f(V_{DS})$ Parameter: $V_{GS} = 0, f = 1$ MHz

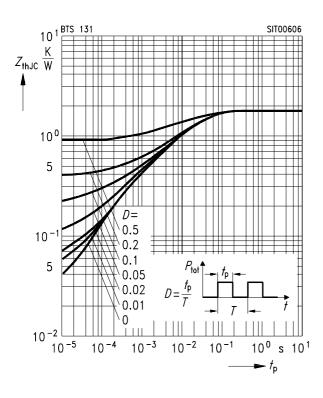




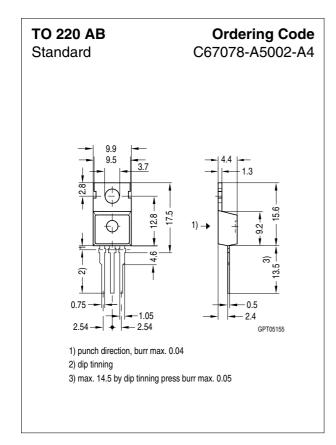


Transient thermal impedance $Z_{\text{thJC}} = f(t_{\text{p}})$

Parameter: $D = t_p/T$









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